



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10552335</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LEE, SANG-YUP</p>
	<p>Examiner</p> <p>Durham, Nathan E</p>	<p>Art Unit</p> <p>3765</p>

Class	SubClass	Date	Examiner
223	85,88,89,92,94,95	10/25/2006	NED
206	278,279,282,284,285,300	10/24/2006	NED
D6	315,318,319	10/25/2006	NED
211	85.3	10/25/2006	NED

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<b>Search Notes</b>  	Application/Control No.  10552335	Applicant(s)/Patent Under Reexamination  LEE, SANG-YUP
	Examiner  Durham, Nathan E	Art Unit  3765

Notes	Date	Examiner
See attached EAST search	10/24/2006	NED
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